

Search Notes 	Application/Control No.	Applicant(s)/Patent under Reexamination
	09/898,452	CHEN ET AL.
	Examiner	Art Unit
	Thien D. Tran	2665

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner
370	282	6/9/2005	TT
	278	6/9/2005	TT

SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR
East	6/9/2005	TT
East	6/9/2005	TT
East	6/9/2005	TT
East	6/9/2005	TT